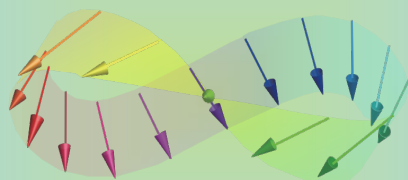


# Information Storage and Spintronics

## Practical Session 3

~ Magnetic Force Microscopy ~



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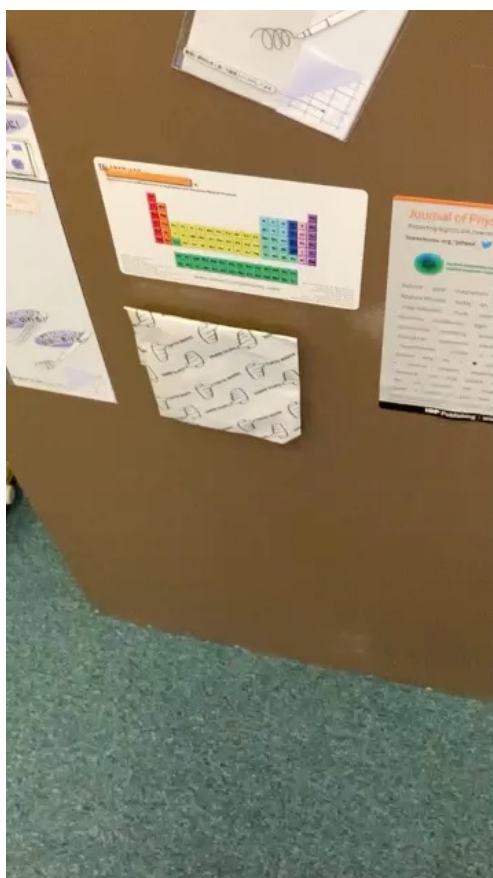
THE UNIVERSITY *of* York



13:00 Wednesday, 26/October/2022



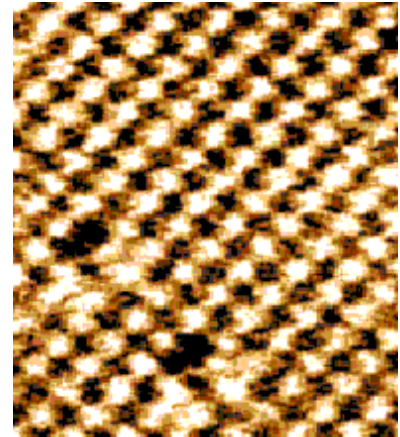
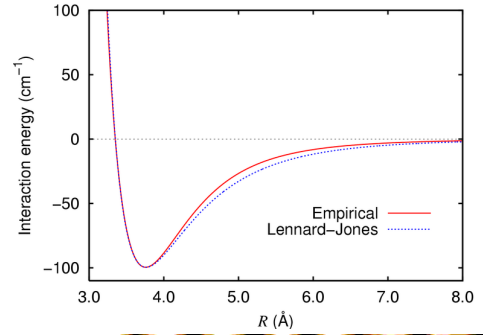
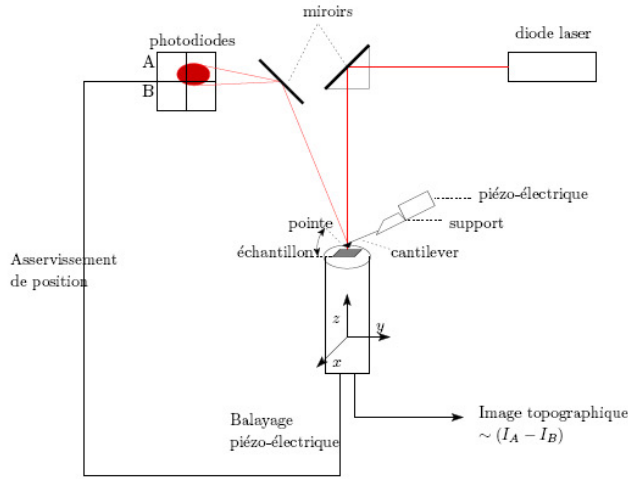
## Magnetic Domain Observation





# Atomic Force Microscope (AFM)

In 1985, Gerd Binnig invented atomic force microscopy :



\* <http://www.wikipedia.org/>

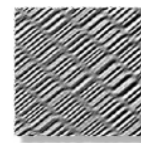
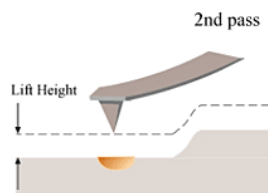
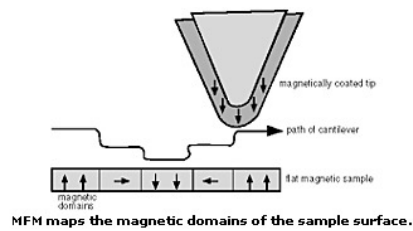
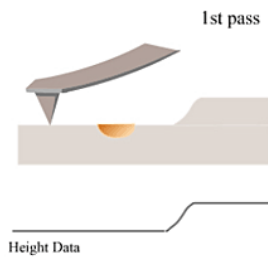
→ Non-conductive surface can be observed.



# Magnetic Force Microscope (MFM)

In 1987, a magnetic tip was introduced to observe a

: \*



MFM image showing the bits of a hard disk.  
30µm. scan

→ By subtracting surface morphology,

are observed.

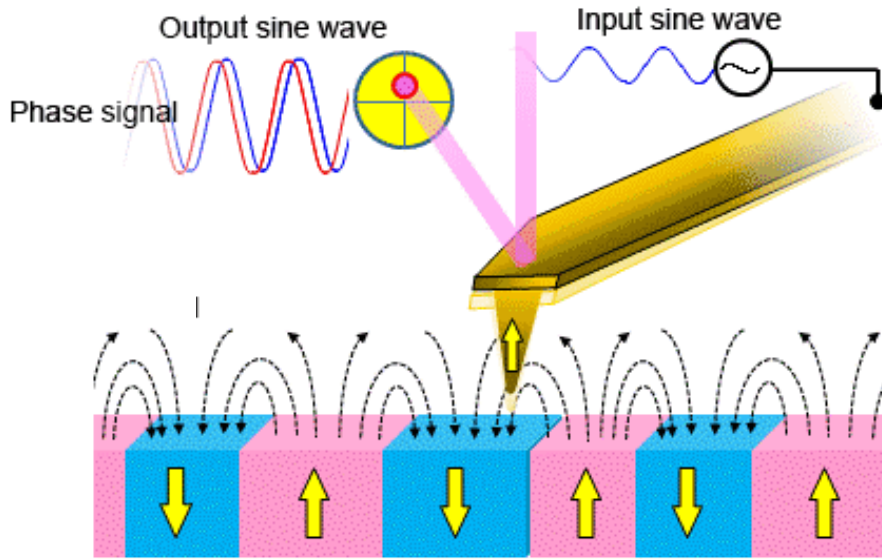
\* Y. Martin, H. K. Wickramasinghe, *Appl. Phys. Lett.* **50**, 1455 (1987).

\*\* <http://www.veeco.com/>



# MFM Operation

The displacement of the magnetic is detected by photodetectors : \*

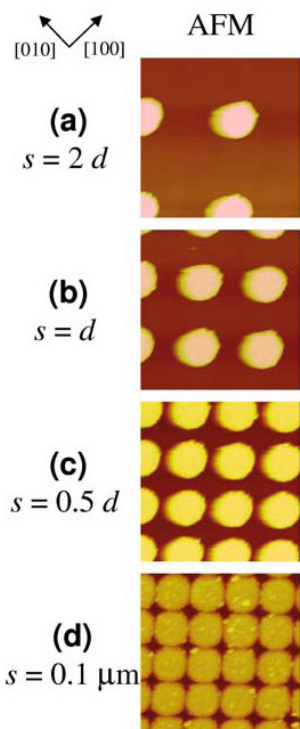


\* <https://www.hitachi-hightech.com/global/science/technical/tech/microscopes/spm/descriptions/electro/mfm.html>

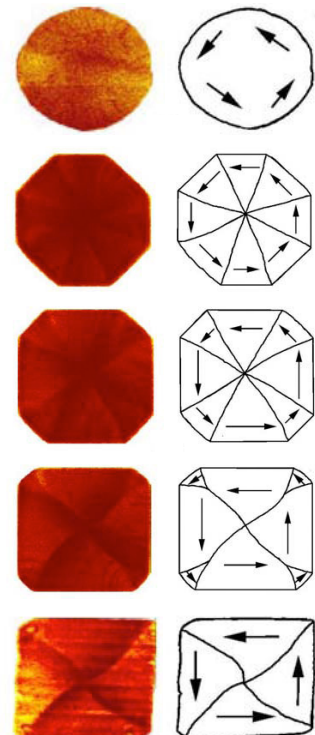


# AFM / MFM Images

MFM images can subtract dots morphology :



20 nm thick Fe dots (1 μm diameter)



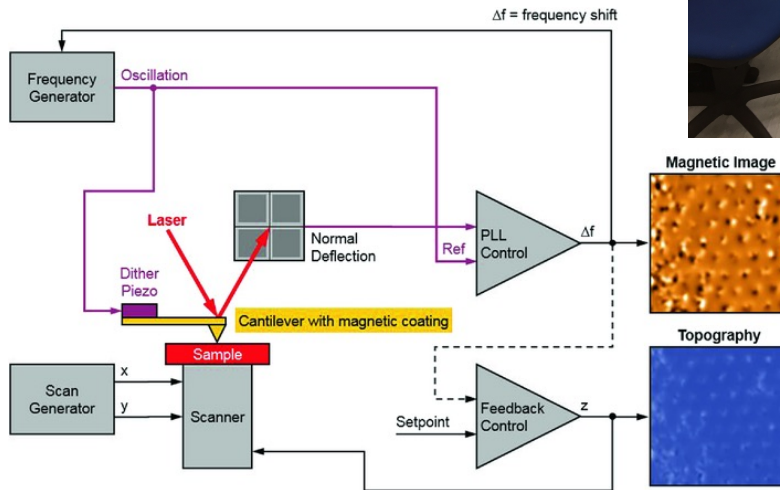
30 nm thick NiFe dots (5 μm)



## AFM / MFM Setup

Nanoscan VLS-80 : \*

- Modes: atomic force microscope (AFM) & magnetic force microscope (MFM)
- In-plane magnetic field: - 5.5 ~ + 5.5 kOe
- Perpendicular magnetic field: - 2.0 ~ + 2.0 kOe
- Stage temperature: room temperature

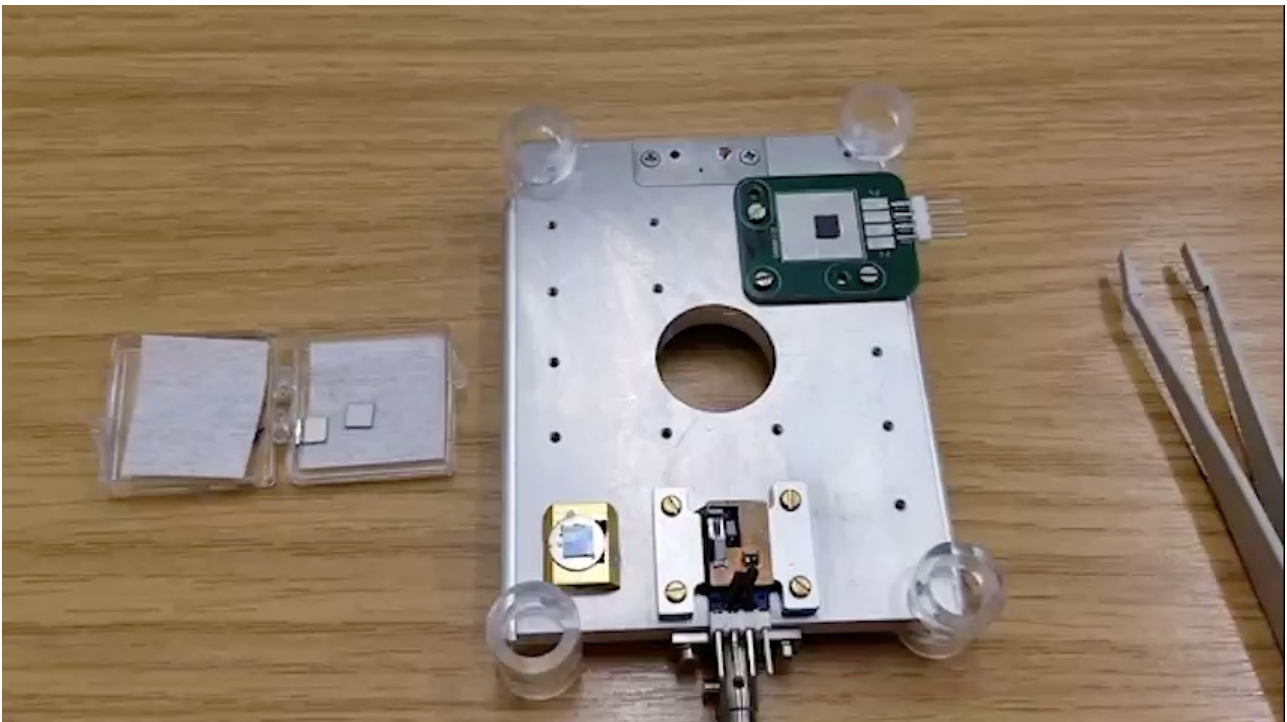


\* A. Hirohata *et al.*, "Magnetic Force Microscopy for Magnetic Recording and Devices," in "Electrical Atomic Force Microscopy for Nanoelectronics," Umberto Celano (Ed.) (Springer, Berlin, Germany, 2019) p. 231-265.



## AFM / MFM Imaging 1

Place a sample on the stage :

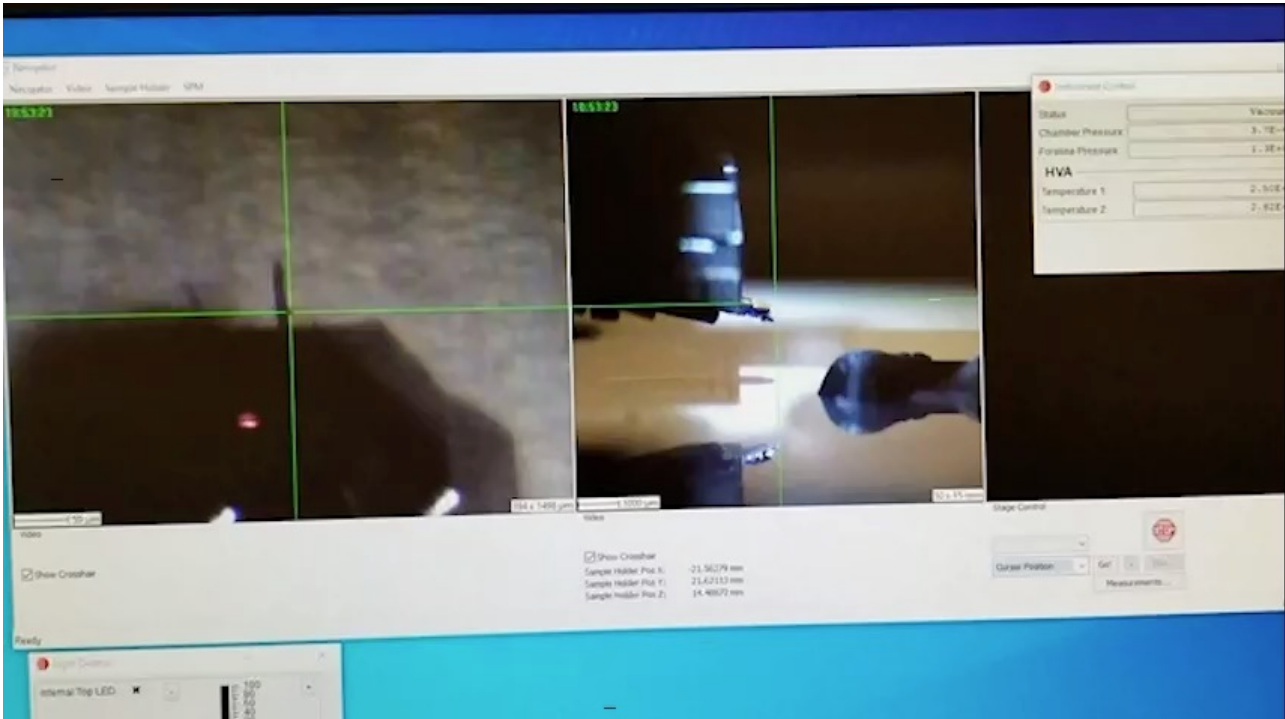






## AFM / MFM Imaging 2

Approach the tip to the sample and execute AFM / MFM imaging :



*Taken by Dr Kelvin Elphick*



## AFM / MFM Analysis

From the MFM image obtained, domain structures need to be sketched (see the slide 5 as an example).

By comparing with the magnetisation curve obtained by VSM, a magnetisation reversal process needs to be discussed.

A modelling software can be used to simulate the magnetisation reversal, such as OOMMF (Object Oriented MicroMagnetic Framework, see the online tutorial at <https://www.spintalks.org/tutorials> and the software details at <https://math.nist.gov/oommf/>)

In the reversal process, magnetic anisotropy needs to be considered and discussed.